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Application/Control No.	Applicant(s)/Patent under Reexamination
10/009,317	SELSTED ET AL.
Examiner	Art Unit
Anand U. Desai, Ph.D.	1656

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
EAST – US-PGPUB, USPAT. See search history printout(s)		12/5/2007	AD	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STIC sequence search. See SCORES database. SEQ ID NO: 32 and SEQ ID NO: 33.	12/3/2007	AD		
EAST – US-PGPUB, USPAT, EPO, JPO, DERWENT. See search history printout(s).	12/4/2007	AD		
EAST – US-PGPUB, USPAT, EPO, JPO, DERWENT. See search history printout(s).	12/5/2007	AD		
Inventor and Assignee search	12/5/2007	AD		
PubMed search (see search history printout(s).	12/5/2007	AD		
Consulted with Examiner A. Navarro	12/3/2007	AD		